Search Notes			

Application/Control	No. Applicant(s)/Patent under Reexamination	•
10/821,503	PARCE ET AL.	
Examiner	Art Unit	
Christopher L. Chin	1641	

SEARCHED				
Class	Subclass	Date	Examiner	
435	7.2			
435	7.21			
435	287.1			
435	288.5			
435	288.7			
436	514			
436	63			
436	164			
436	172			
436	804			
436	805	2/18/2006	СС	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Same as	above	2/18/2006	СС	

(INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
		